

Notice of References Cited	Application/Control No. 09/749,826	Applicant(s)/Patent Under Reexamination HICKS ET AL.	
	Examiner Chris Parry	Art Unit 2623	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,889,385	05-2005	Rakib et al.	725/119
*	B	US-6,637,031	10-2003	Chou, Philip A.	725/87
*	C	US-2002/0009149	01-2002	Rodriguez et al.	375/240.25
*	D	US-6,317,884	11-2001	Eames et al.	709/217
*	E	US-2002/0152311	10-2002	VELTMAN et al.	709/227
*	F	US-6,611,537	08-2003	Edens et al.	370/503
*	G	US-6,633,547	10-2003	Akatsu et al.	370/255
*	H	US-6,526,581	02-2003	Edson, Richard	725/74
*	I	US-6,526,580	02-2003	Shimomura et al.	725/63
*	J	US-6,202,211	03-2001	Williams, Jr., Henry R.	725/78
*	K	US-6,081,533	06-2000	Laubach et al.	370/421
*	L	US-6,628,891	09-2003	Vantalón et al.	386/94
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.